Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10659744	NABEYAMA ET AL.
Examiner	Art Unit
Tran, Dzung D	2613

SEARCHED			
Class	Subclass	Date	Examiner
398	81, 147	12/09/2007	TD
	Update search	06/22/2008	TD
	Update search	12/20/2008	TD

SEARCH NOTES		
Search Notes	Date	Examiner
398/class as listed (USPAT; US-PGPUB; EPO; JPO and text search). See search history printout	12/09/2007	TD

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

1	

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